

SN54ALS1003A, SN74ALS1003A QUADRUPLE 2-INPUT POSITIVE-NAND BUFFERS WITH OPEN-COLLECTOR OUTPUTS

SDAS239 – D2661, APRIL 1982 – REVISED MAY 1986

- Buffer Version of 'ALS03B
- Package Options include Plastic Small Outline Packages, Ceramic Chip Carriers, and Standard Plastic and Ceramic 300-mil DIPs
- Dependable Texas Instruments Quality and Reliability

description

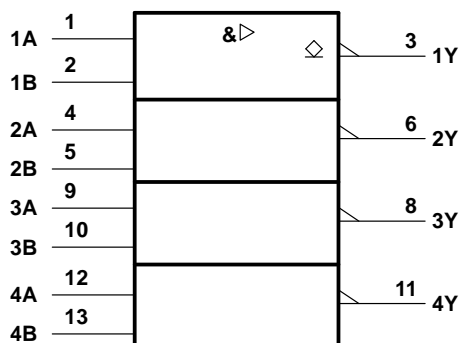
These devices contain four independent 2-input NAND buffers. They perform the Boolean functions $Y = \overline{A \cdot B}$ or $Y = \overline{A + B}$ in positive logic. The open-collector outputs require pullup resistors to perform correctly. They may be connected to other open-collector outputs to implement active-low wired-OR or active-high wired-AND functions. Open-collector devices are often used to generate higher V_{OH} levels.

The SN54ALS1003A is characterized for operation over the full military temperature range of -55°C to 125°C . The SN74ALS1003A is characterized for operation from 0°C to 70°C .

FUNCTION TABLE
(each gate)

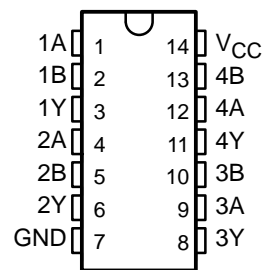
INPUTS		OUTPUT
A	B	Y
H	H	L
L	X	H
X	L	H

logic symbol†

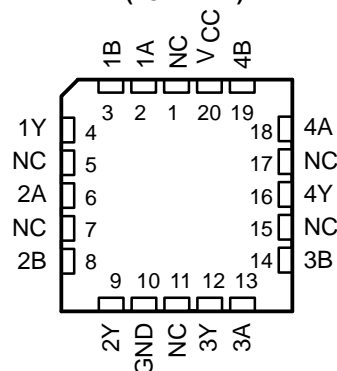


† This symbol is in accordance with ANSI/IEEE Std 91-1984 and IEC Publication 617-12.
Pin numbers shown are for D, J, and N packages.

**SN54ALS1003A ... J PACKAGE
SN74ALS1003A ... D OR N PACKAGE**
(TOP VIEW)

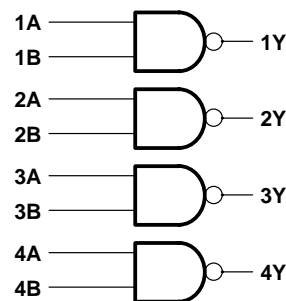


SN54ALS1003A ... FK PACKAGE
(TOP VIEW)



NC – No internal connection

logic diagram (positive logic)



SN54ALS1003A, SN74ALS1003A

QUADRUPLE 2-INPUT POSITIVE-NAND BUFFERS

WITH OPEN-COLLECTOR OUTPUTS

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absolute maximum ratings over operating free-air temperature range (unless otherwise noted)

Supply voltage, V_{CC}	7 V
Input voltage	7 V
Off-state output voltage	7 V
Operating free-air temperature range: SN54ALS1003A	–55°C to 125°C
SN74ALS1003A	0°C to 70°C
Storage temperature range	–65°C to 150°C

recommended operating conditions

		SN54ALS1003A			SN74ALS1003A			UNIT
		MIN	NOM	MAX	MIN	NOM	MAX	
V_{CC}	Supply voltage	4.5	5	5.5	4.5	5	5.5	V
V_{IH}	High-level input voltage	2			2			V
V_{IL}	Low-level input voltage			0.7			0.8	V
V_{OH}	High-level output voltage			5.5			5.5	V
I_{OL}	Low-level output current			12			24	mA
T_A	Operating free-air temperature	–55		125	0		70	°C

electrical characteristics over recommended operating-free-air temperature range (unless otherwise noted)

PARAMETER	TEST CONDITIONS		SN54ALS1003A		SN74ALS1003A		UNIT		
			MIN	TYP†	MAX	MIN		TYP†	MAX
V _{IK}	V _{CC} = 4.5 V,	I _I = −18 mA			−1.5		−1.5	V	
V _{OL}	V _{CC} = 4.5 V,	I _{OL} = 12 mA		0.25	0.4		0.25	0.4	V
	V _{CC} = 4.5 V,	I _{OL} = 24 mA					0.35	0.5	
I _{OH}	V _{CC} = 4.5 V,	V _{OH} = 5.5 V			0.1			0.1	mA
I _I	V _{CC} = 5.5 V,	V _I = 7 V			0.1			0.1	mA
I _{IH}	V _{CC} = 5.5 V,	V _I = 2.7 V			20			20	μA
I _{IL}	V _{CC} = 5.5 V,	V _I = 0.4 V			−0.1			−0.1	mA
I _{CCH}	V _{CC} = 5.5 V,	V _I = 0		0.86	1.6		0.86	1.6	mA
I _{CCL}	V _{CC} = 5.5 V,	V _I = 4.5 V		4.8	7.8		4.8	7.8	mA

† All typical values are at $V_{CC} = 5$ V, $T_A = 25^\circ\text{C}$.

switching characteristics (see Note 1)

PARAMETER	FROM (INPUT)	TO (OUTPUT)	$V_{CC} = 5\text{ V},$ $C_L = 50\text{ pF},$ $R_L = 680\ \Omega,$ $T_A = 25^\circ\text{C}$	$V_{CC} = 4.5\text{ V to }5.5\text{ V},$ $C_L = 50\text{ pF},$ $R_L = 680\ \Omega,$ $T_A = \text{MIN to MAX}$				UNIT
			'ALS1003A	SN54ALS1003A		SN74ALS1003A		
			TYP	MIN	MAX	MIN	MAX	
t _{PLH}	A or B	Y	18	10	40	10	33	ns
t _{PHL}	A or B	Y	7	2	18	2	12	ns

NOTE 1: Load circuit and voltage waveforms are shown in Section 1.



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